

### CoolSiC™ 1200 V SiC Trench MOSFET : silicon carbide MOSFET

#### Features

- $V_{DSS} = 1200\text{ V}$  at  $T_{vj} = 25^\circ\text{C}$
- $I_{DCC} = 127\text{ A}$  at  $T_{vj} = 25^\circ\text{C}$
- $R_{DS(on)} = 14\text{ m}\Omega$  at  $V_{GS} = 18\text{ V}$ ,  $T_{vj} = 25^\circ\text{C}$
- Very low switching losses
- Short circuit withstand time  $3\ \mu\text{s}$
- Benchmark gate threshold voltage,  $V_{GS(th)} = 4.2\text{ V}$
- Robust against parasitic turn on,  $0\text{ V}$  turn-off gate voltage can be applied
- Robust body diode for hard commutation
- .XT interconnection technology for best-in-class thermal performance

#### Potential applications

- General purpose drives (GPD)
- EV-Charging
- Online UPS/Industrial UP
- String inverters
- Solar power optimizer

#### Product validation

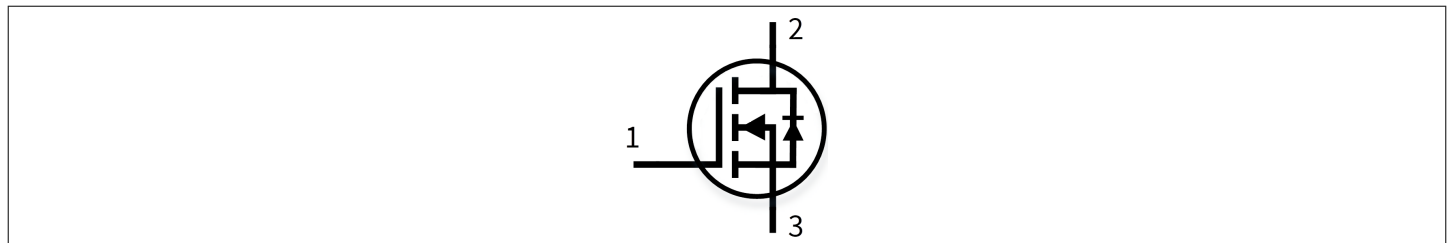
- Qualified for industrial applications according to the relevant tests of JEDEC47/20/22
- Please also note the application note AN2019-05 for power and thermal cycling

#### Description

- 1 – gate
- 2 – drain
- 3 – source



- Lead-Free
- Green
- Halogen-Free
- RoHS



| Type          | Package             | Marking  |
|---------------|---------------------|----------|
| IMW120R014M1H | PG-TO247-3-STD-N2.5 | 12M1H014 |

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## 1 Package

**Table 1** Characteristic values

| Parameter                            | Symbol        | Note or test condition                               | Values |      |      | Unit |
|--------------------------------------|---------------|--|--------|------|------|------|
|                                      |               |  | Min.   | Typ. | Max. |      |
| Storage temperature                  | $T_{stg}$     |  | -55    |      | 150  | °C   |
| Soldering temperature                |               | wave soldering 1.6 mm (0.063 in.) from case for 10 s |        |      | 260  | °C   |
| Mounting torque                      | $M$           | M3 screw Maximum of mounting process: 3              |        |      | 0.6  | Nm   |
| Thermal resistance, junction-ambient | $R_{th(j-a)}$ |  |        |      | 62   | K/W  |

## 2 MOSFET

**Table 2** Maximum rated values

| Parameter  | Symbol    | Note or test condition   | Values                | Unit          |   |
|--|-----------|--|-----------------------|---------------|---|
| Drain-source voltage   | $V_{DSS}$ | $T_{vj} \geq 25\text{ °C}$   | 1200                  | V             |   |
| Continuous DC drain current for $R_{th(j-c,max)}$ , limited by $T_{vj(max)}$ | $I_{DDC}$ | $V_{GS} = 18\text{ V}$   | $T_c = 25\text{ °C}$  | 127           | A |
|  |           |  | $T_c = 100\text{ °C}$ | 89.3          |   |
| Peak drain current, $t_p$ limited by $T_{vj(max)}$                           | $I_{DM}$  | $V_{GS} = 18\text{ V}$   | 267.9                 | A             |   |
| Gate-source voltage, max. transient voltage <sup>1)</sup>                    | $V_{GS}$  | $t_p \leq 0.5\ \mu\text{s}$ , $D < 0.001$  | -10/23                | V             |   |
| Gate-source voltage, max. static voltage                                     | $V_{GS}$  |  | -5/20                 | V             |   |
| Avalanche energy, single pulse   | $E_{AS}$  | $I_D = 53\text{ A}$ , $V_{DD} = 50\text{ V}$ , $L = 0.7\text{ mH}$   | 956                   | mJ            |   |
| Avalanche energy, repetitive   | $E_{AR}$  | $I_D = 53\text{ A}$ , $V_{DD} = 50\text{ V}$ , $L = 3.3\ \mu\text{H}$  | 4.7                   | mJ            |   |
| Short-circuit withstand time   | $t_{SC}$  | $V_{DD} \leq 800\text{ V}$ , $V_{DS,peak} < 1200\text{ V}$ , $V_{GS(on)} = 15\text{ V}$ , $T_{vj(start)} = 25\text{ °C}$ | 3                     | $\mu\text{s}$ |   |
| MOSFET dv/dt robustness  | $dv/dt$   | $V_{DS} = 0 \dots 800\text{ V}$  | 150                   | V/ns          |   |
| Power dissipation, limited by $T_{vj(max)}$                                  | $P_{tot}$ |  | $T_c = 25\text{ °C}$  | 455           | W |
|  |           |  | $T_c = 100\text{ °C}$ | 227           |   |

<sup>1)</sup> Important note: The selection of positive and negative gate-source voltages impacts the long-term behavior of the device. The design guidelines described in Application Note AN2018-09 must be considered to ensure sound operation of the device over the planned lifetime.

**Table 3 Recommended values**

| Parameter                         | Symbol        | Note or test condition | Values  | Unit |
|-----------------------------------|---------------|------------------------|---------|------|
| Recommended turn-on gate voltage  | $V_{GS(on)}$  |                        | 15...18 | V    |
| Recommended turn-off gate voltage | $V_{GS(off)}$ |                        | -5...0  | V    |

**Table 4 Characteristic values**

| Parameter                        | Symbol       | Note or test condition   | Values   |      |      | Unit |    |
|----------------------------------|--------------|--|--|------|------|------|----|
|                                  |              |  | Min.   | Typ. | Max. |      |    |
| Drain-source on-state resistance | $R_{DS(on)}$ | $I_D = 54.3 \text{ A}$   | $T_{vj} = 25 \text{ }^\circ\text{C}$ ,<br>$V_{GS(on)} = 18 \text{ V}$  |      | 14   | 18.4 | mΩ |
|                                  |              |  | $T_{vj} = 100 \text{ }^\circ\text{C}$ ,<br>$V_{GS(on)} = 18 \text{ V}$ |      | 19   |      |    |
|                                  |              |  | $T_{vj} = 175 \text{ }^\circ\text{C}$ ,<br>$V_{GS(on)} = 18 \text{ V}$ |      | 27   |      |    |
|                                  |              |  | $T_{vj} = 25 \text{ }^\circ\text{C}$ ,<br>$V_{GS(on)} = 15 \text{ V}$  |      | 17.9 | 21.9 |    |
| Gate-emitter threshold voltage   | $V_{GS(th)}$ | $I_D = 23.4 \text{ mA}$ , $V_{DS} = V_{GS}$<br>(tested after 1 ms pulse at $V_{GS} = 20 \text{ V}$ ) | $T_{vj} = 25 \text{ }^\circ\text{C}$                                   | 3.5  | 4.2  | 5.2  | V  |
|                                  |              |  | $T_{vj} = 175 \text{ }^\circ\text{C}$                                  |      | 3.6  |      |    |
| Zero gate-voltage drain current  | $I_{DSS}$    | $V_{DS} = 1200 \text{ V}$ , $V_{GS} = 0 \text{ V}$   | $T_{vj} = 25 \text{ }^\circ\text{C}$                                   |      |      | 430  | μA |
|                                  |              |  | $T_{vj} = 175 \text{ }^\circ\text{C}$                                  |      | 7286 |      |    |
| Gate leakage current             | $I_{GSS}$    | $V_{DS} = 0 \text{ V}$   | $V_{GS} = 23 \text{ V}$  |      |      | 200  | nA |
|                                  |              |  | $V_{GS} = -10 \text{ V}$   |      |      | -200 |    |
| Forward transconductance         | $g_{fs}$     | $I_D = 54.3 \text{ A}$ , $V_{DS} = 20 \text{ V}$   |  | 36.3 |      | S    |    |
| Internal gate resistance         | $R_{G,int}$  | $f = 1 \text{ MHz}$ , $V_{AC} = 25 \text{ mV}$   |  | 3.7  |      | Ω    |    |
| Input capacitance                | $C_{iss}$    | $V_{DD} = 25 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $f = 100 \text{ kHz}$ , $V_{AC} = 25 \text{ mV}$  |  | 4580 |      | nF   |    |
| Output capacitance               | $C_{oss}$    | $V_{DD} = 25 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $f = 100 \text{ kHz}$ , $V_{AC} = 25 \text{ mV}$  |  | 211  |      | pF   |    |
| Reverse transfer capacitance     | $C_{rss}$    | $V_{DD} = 25 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $f = 100 \text{ kHz}$ , $V_{AC} = 25 \text{ mV}$  |  | 30   |      | pF   |    |
| $C_{oss}$ stored energy          | $E_{oss}$    | $V_{DD} = 25 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $f = 100 \text{ kHz}$ , $V_{AC} = 25 \text{ mV}$  |  | 86   |      | μJ   |    |
| Total gate charge                | $Q_G$        | $V_{DD} = 800 \text{ V}$ , $I_D = 54.3 \text{ A}$ , $V_{GS} = 0/18 \text{ V}$ , turn-on pulse        |  | 110  |      | nC   |    |
| Plateau gate charge              | $Q_{GS(pl)}$ | $V_{DD} = 800 \text{ V}$ , $I_D = 54.3 \text{ A}$ , $V_{GS} = 0/18 \text{ V}$ , turn-on pulse        |  | 36   |      | nC   |    |
| Gate-to-drain charge             | $Q_{GD}$     | $V_{DD} = 800 \text{ V}$ , $I_D = 54.3 \text{ A}$ , $V_{GS} = 0/18 \text{ V}$ , turn-on pulse        |  | 32   |      | nC   |    |

(table continues...)

**Table 4 (continued) Characteristic values**

| Parameter              | Symbol       | Note or test condition  | Values                               |      |      | Unit          |
|------------------------|--------------|---|--------------------------------------|------|------|---------------|
|                        |              |   | Min.                                 | Typ. | Max. |               |
| Turn-on delay time     | $t_{d(on)}$  | $V_{DD} = 800\text{ V}, I_D = 54.3\text{ A},$<br>$V_{GS} = 0/18\text{ V},$<br>$R_{GS(on)} = 1\ \Omega,$<br>$R_{GS(off)} = 1\ \Omega,$ diode:<br>body diode at $V_{GS} = 0\text{ V},$<br>$L_\sigma = 15\text{ nH}$ | $T_{vj} = 25\text{ }^\circ\text{C}$  |      | 31   | ns            |
|                        |              |   | $T_{vj} = 175\text{ }^\circ\text{C}$ |      | 28   |               |
| Rise time              | $t_r$        | $V_{DD} = 800\text{ V}, I_D = 54.3\text{ A},$<br>$V_{GS} = 0/18\text{ V},$<br>$R_{GS(on)} = 1\ \Omega,$<br>$R_{GS(off)} = 1\ \Omega,$ diode:<br>body diode at $V_{GS} = 0\text{ V},$<br>$L_\sigma = 15\text{ nH}$ | $T_{vj} = 25\text{ }^\circ\text{C}$  |      | 29   | ns            |
|                        |              |   | $T_{vj} = 175\text{ }^\circ\text{C}$ |      | 37   |               |
| Turn-off delay time    | $t_{d(off)}$ | $V_{DD} = 800\text{ V}, I_D = 54.3\text{ A},$<br>$V_{GS} = 0/18\text{ V},$<br>$R_{GS(on)} = 1\ \Omega,$<br>$R_{GS(off)} = 1\ \Omega,$ diode:<br>body diode at $V_{GS} = 0\text{ V},$<br>$L_\sigma = 15\text{ nH}$ | $T_{vj} = 25\text{ }^\circ\text{C}$  |      | 38   | ns            |
|                        |              |   | $T_{vj} = 175\text{ }^\circ\text{C}$ |      | 42   |               |
| Fall time              | $t_f$        | $V_{DD} = 800\text{ V}, I_D = 54.3\text{ A},$<br>$V_{GS} = 0/18\text{ V},$<br>$R_{GS(on)} = 1\ \Omega,$<br>$R_{GS(off)} = 1\ \Omega,$ diode:<br>body diode at $V_{GS} = 0\text{ V},$<br>$L_\sigma = 15\text{ nH}$ | $T_{vj} = 25\text{ }^\circ\text{C}$  |      | 22   | ns            |
|                        |              |   | $T_{vj} = 175\text{ }^\circ\text{C}$ |      | 22   |               |
| Turn-on energy         | $E_{on}$     | $V_{DD} = 800\text{ V}, I_D = 54.3\text{ A},$<br>$V_{GS} = 0/18\text{ V},$<br>$R_{GS(on)} = 1\ \Omega,$<br>$R_{GS(off)} = 1\ \Omega,$ diode:<br>body diode at $V_{GS} = 0\text{ V},$<br>$L_\sigma = 15\text{ nH}$ | $T_{vj} = 25\text{ }^\circ\text{C}$  |      | 1340 | $\mu\text{J}$ |
|                        |              |   | $T_{vj} = 175\text{ }^\circ\text{C}$ |      | 1640 |               |
| Turn-off energy        | $E_{off}$    | $V_{DD} = 800\text{ V}, I_D = 54.3\text{ A},$<br>$V_{GS} = 0/18\text{ V},$<br>$R_{GS(on)} = 1\ \Omega,$<br>$R_{GS(off)} = 1\ \Omega,$ diode:<br>body diode at $V_{GS} = 0\text{ V},$<br>$L_\sigma = 15\text{ nH}$ | $T_{vj} = 25\text{ }^\circ\text{C}$  |      | 470  | $\mu\text{J}$ |
|                        |              |   | $T_{vj} = 175\text{ }^\circ\text{C}$ |      | 510  |               |
| Total switching energy | $E_{tot}$    | $V_{DD} = 800\text{ V}, I_D = 54.3\text{ A},$<br>$V_{GS} = 0/18\text{ V},$<br>$R_{GS(on)} = 1\ \Omega,$<br>$R_{GS(off)} = 1\ \Omega,$ diode:<br>body diode at $V_{GS} = 0\text{ V},$<br>$L_\sigma = 15\text{ nH}$ | $T_{vj} = 25\text{ }^\circ\text{C}$  |      | 2050 | $\mu\text{J}$ |
|                        |              |   | $T_{vj} = 175\text{ }^\circ\text{C}$ |      | 2797 |               |

(table continues...)

**Table 4 (continued) Characteristic values**

| Parameter  | Symbol        | Note or test condition | Values |      |      | Unit |
|--|---------------|------------------------|--------|------|------|------|
|  |               |                        | Min.   | Typ. | Max. |      |
| MOSFET/body diode thermal resistance, junction to case | $R_{th(j-c)}$ |                        |        | 0.25 | 0.33 | K/W  |
| Virtual junction temperature                           | $T_{vj}$      |                        | -55    |      | 175  | °C   |

*Note:* For optimum lifetime and reliability, Infineon recommends operating conditions that do not exceed 80% of the maximum ratings stated in this datasheet.

The chip technology was characterized up to 200 kV/μs. The measured dV/dt was limited by measurement test setup and package.

Dynamic test circuit see Fig. F.

### 3 Body diode

**Table 5 Maximum rated values**

| Parameter   | Symbol    | Note or test condition     | Values                | Unit |   |
|---|-----------|----------------------------|-----------------------|------|---|
| Drain-source voltage  | $V_{DSS}$ | $T_{vj} \geq 25\text{ °C}$ | 1200                  | V    |   |
| Continuous reverse drain current for $R_{th(j-c,max)}$ , limited by $T_{vj(max)}$ | $I_{SDC}$ | $V_{GS} = 0\text{ V}$      | $T_c = 25\text{ °C}$  | 95   | A |
|   |           |                            | $T_c = 100\text{ °C}$ | 55   |   |
| Peak reverse drain current, $t_p$ limited by $T_{vj(max)}$                        | $I_{SM}$  | $V_{GS} = 0\text{ V}$      | 267.9                 | A    |   |

**Table 6 Characteristic values**

| Parameter                            | Symbol    | Note or test condition   | Values                   |      |      | Unit |
|--------------------------------------|-----------|--|--------------------------|------|------|------|
|                                      |           |  | Min.                     | Typ. | Max. |      |
| Drain-source reverse voltage         | $V_{SD}$  | $I_{SD} = 54.3\text{ A}, V_{GS} = 0\text{ V}$  | $T_{vj} = 25\text{ °C}$  | 3.8  | 5    | V    |
|                                      |           |  | $T_{vj} = 100\text{ °C}$ | 3.7  |      |      |
|                                      |           |  | $T_{vj} = 175\text{ °C}$ | 3.6  |      |      |
| MOSFET forward recovery charge       | $Q_{fr}$  | $V_{DD} = 800\text{ V}, I_{SD} = 54.3\text{ A}, V_{GS} = 0\text{ V}, di_f/dt = 3000\text{ A}/\mu\text{s}, Q_f$ includes also $Q_C$ | $T_{vj} = 25\text{ °C}$  | 450  |      | nC   |
|                                      |           |  | $T_{vj} = 175\text{ °C}$ | 825  |      |      |
| MOSFET peak forward recovery current | $I_{frm}$ | $V_{DD} = 800\text{ V}, I_{SD} = 54.3\text{ A}, V_{GS} = 0\text{ V}, di_f/dt = 3000\text{ A}/\mu\text{s}, Q_f$ includes also $Q_C$ | $T_{vj} = 25\text{ °C}$  | 13   |      | A    |
|                                      |           |  | $T_{vj} = 175\text{ °C}$ | 16   |      |      |

**(table continues...)**

**Table 6** (continued) **Characteristic values**

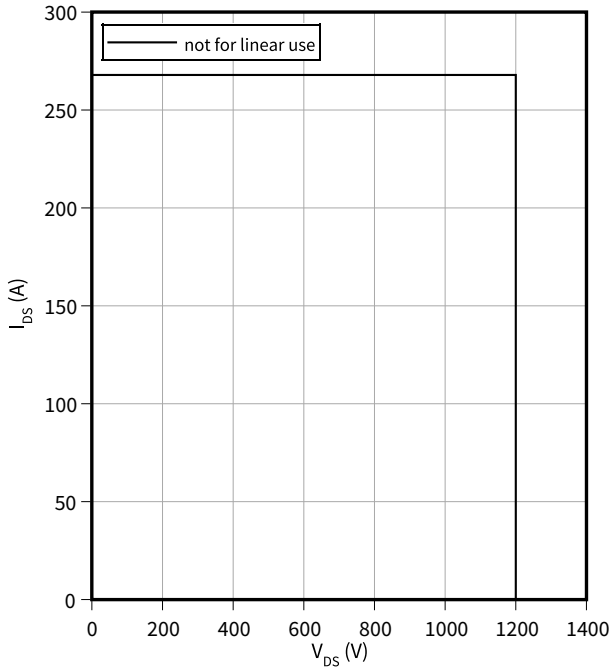
| Parameter                      | Symbol   | Note or test condition  | Values                                |      |      | Unit             |
|--------------------------------|----------|---|---------------------------------------|------|------|------------------|
|                                |          |   | Min.                                  | Typ. | Max. |                  |
| MOSFET forward recovery energy | $E_{fr}$ | $V_{DD} = 800 \text{ V}$ ,<br>$I_{SD} = 54.3 \text{ A}$ , $V_{GS} = 0 \text{ V}$ ,<br>$di_f/dt = 3000 \text{ A}/\mu\text{s}$ , $Q_f$<br>includes also $Q_C$ | $T_{vj} = 25 \text{ }^\circ\text{C}$  |      | 240  | $\mu\text{J}$    |
|                                |          |   | $T_{vj} = 175 \text{ }^\circ\text{C}$ |      | 647  |                  |
| Virtual junction temperature   | $T_{vj}$ |   | -55                                   |      | 175  | $^\circ\text{C}$ |

## 4 Characteristics diagrams

### Reverse bias safe operating area (RBSOA), MOSFET

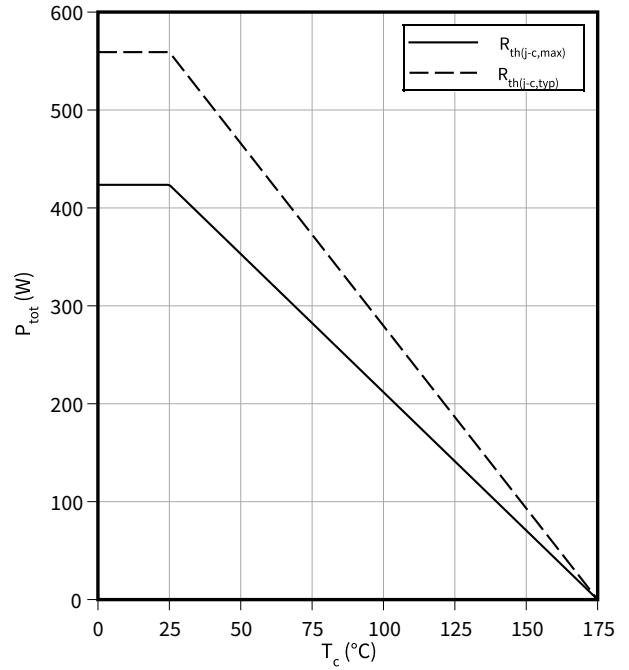
$$I_{DS} = f(V_{DS})$$

$$T_{vj} \leq 175\text{ °C}, V_{GS} = 0/18\text{ V}, T_c = 25\text{ °C}$$



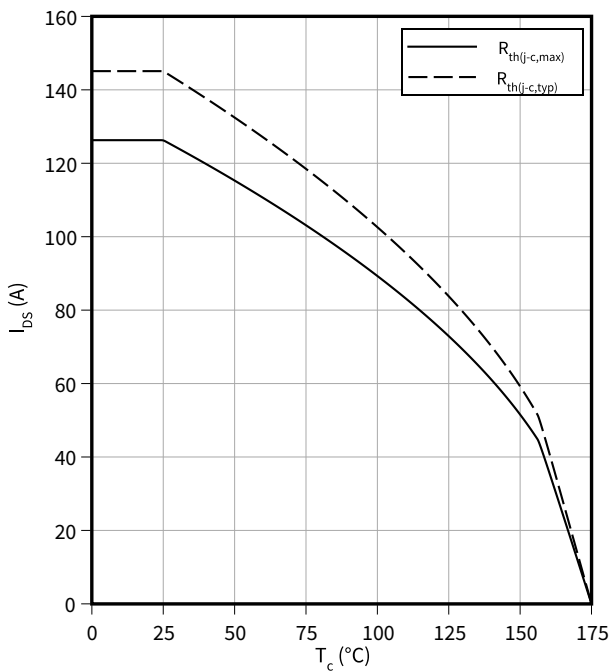
### Power dissipation as a function of case temperature limited by bond wire, MOSFET

$$P_{tot} = f(T_c)$$



### Maximum DC drain to source current as a function of case temperature limited by bond wire, MOSFET

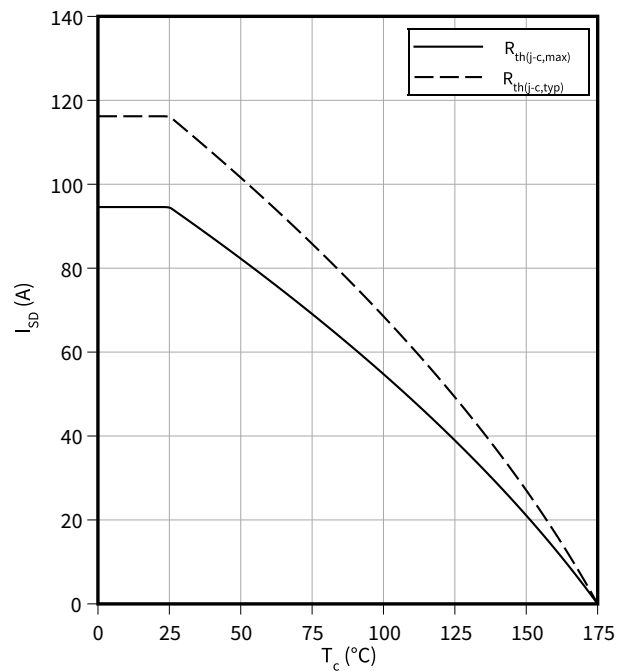
$$I_{DS} = f(T_c)$$



### Maximum source to drain current as a function of case temperature limited by bond wire, MOSFET

$$I_{SD} = f(T_c)$$

$$V_{GS} = 0\text{ V}$$

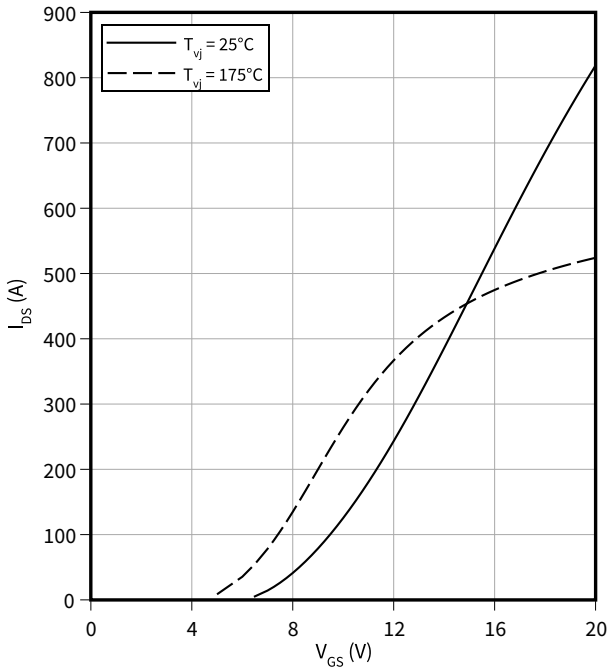




4 Characteristics diagrams

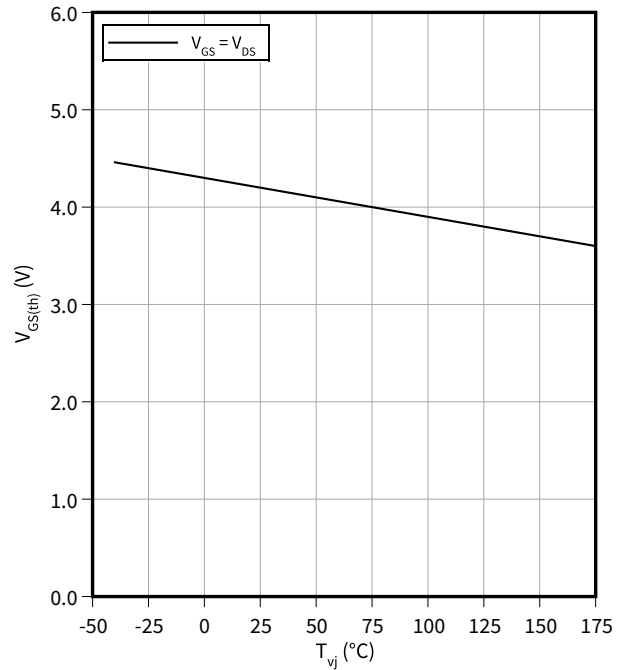
**Typical transfer characteristic, MOSFET**

$I_{DS} = f(V_{GS})$   
 $V_{DS} = 20\text{ V}$ ,  $t_p = 20\ \mu\text{s}$



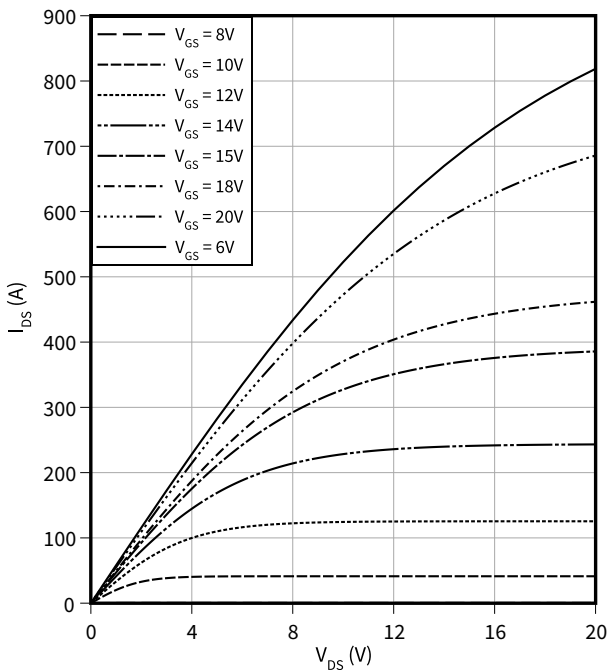
**Typical gate-source threshold voltage as a function of junction temperature, MOSFET**

$V_{GS(th)} = f(T_{vj})$   
 $I_D = 23.4\text{ mA}$



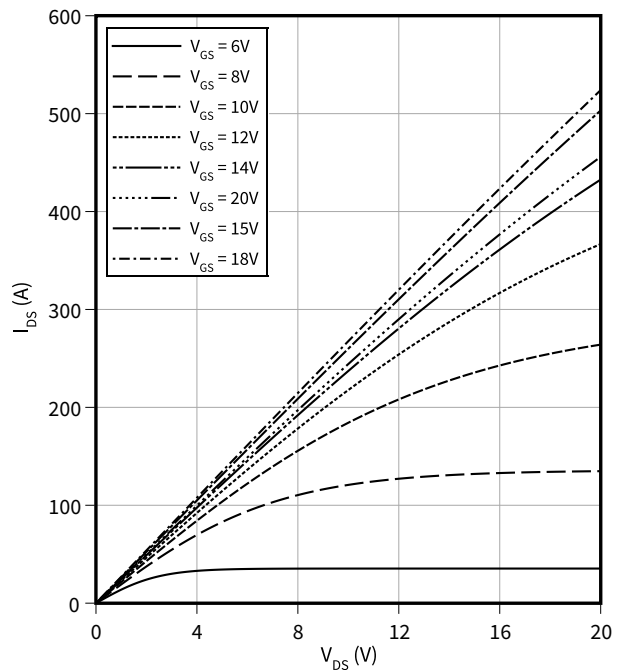
**Typical output characteristic,  $V_{GS}$  as parameter, MOSFET**

$I_{DS} = f(V_{DS})$   
 $T_{vj} = 25\ ^\circ\text{C}$ ,  $t_p = 20\ \mu\text{s}$



**Typical output characteristic,  $V_{GS}$  as parameter, MOSFET**

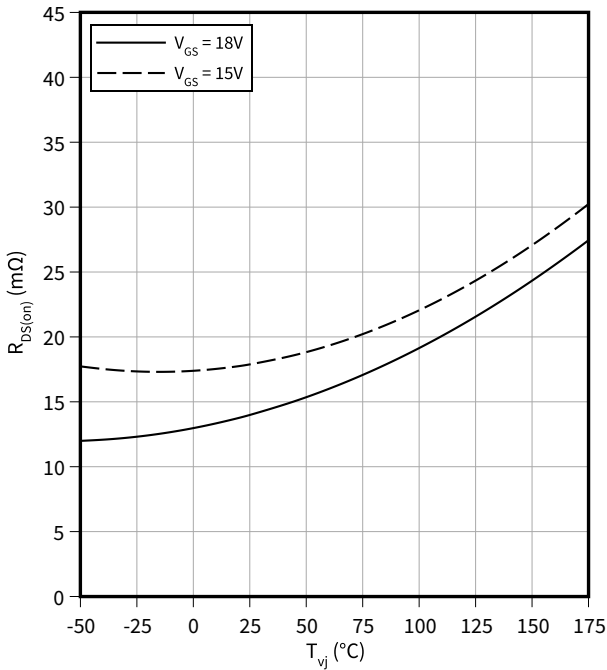
$I_{DS} = f(V_{DS})$   
 $T_{vj} = 175\ ^\circ\text{C}$ ,  $t_p = 20\ \mu\text{s}$



4 Characteristics diagrams

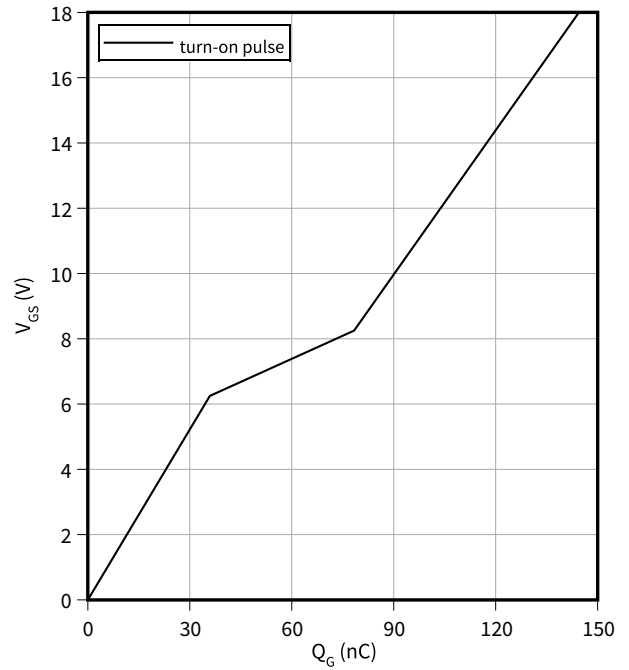
**Typical on-state resistance as a function of junction temperature, MOSFET**

$R_{DS(on)} = f(T_{vj})$   
 $I_D = 54.3 \text{ A}$



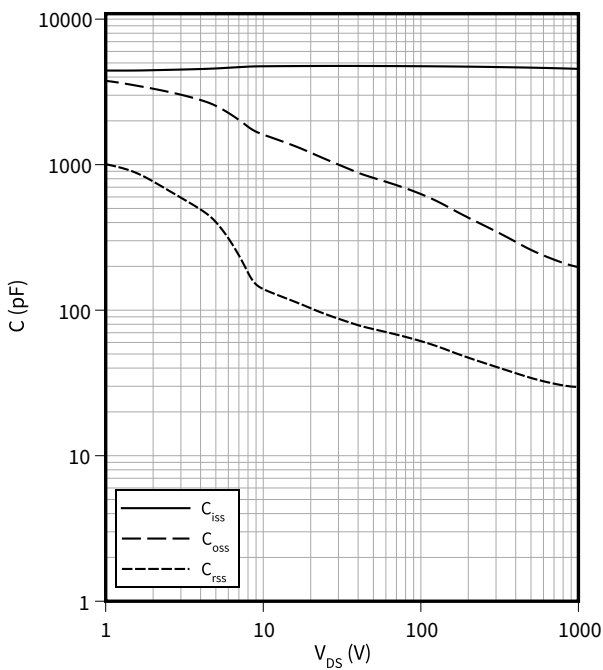
**Typical gate charge , MOSFET**

$V_{GS} = f(Q_G)$   
 $I_D = 54.3 \text{ A}, V_{DS} = 800 \text{ V}$



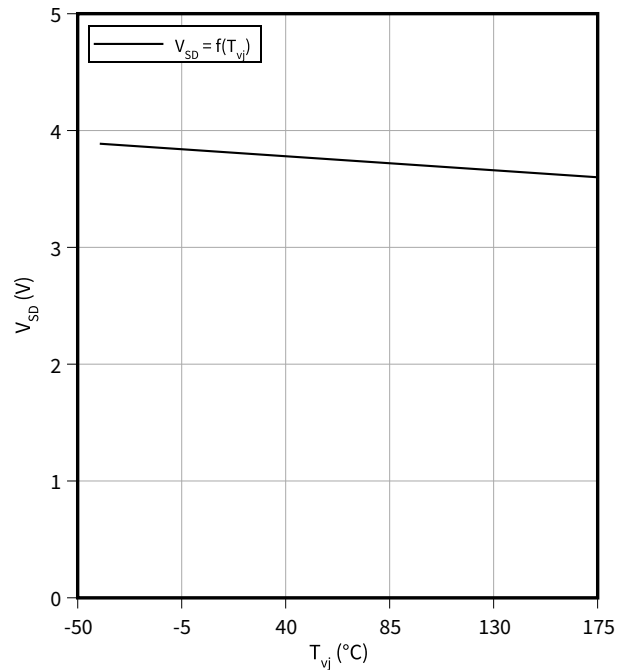
**Typical capacitance as a function of drain-source voltage , MOSFET**

$C = f(V_{DS})$   
 $f = 100 \text{ kHz}, V_{GS} = 0 \text{ V}$



**Typical reverse drain voltage as function of junction temperature , MOSFET**

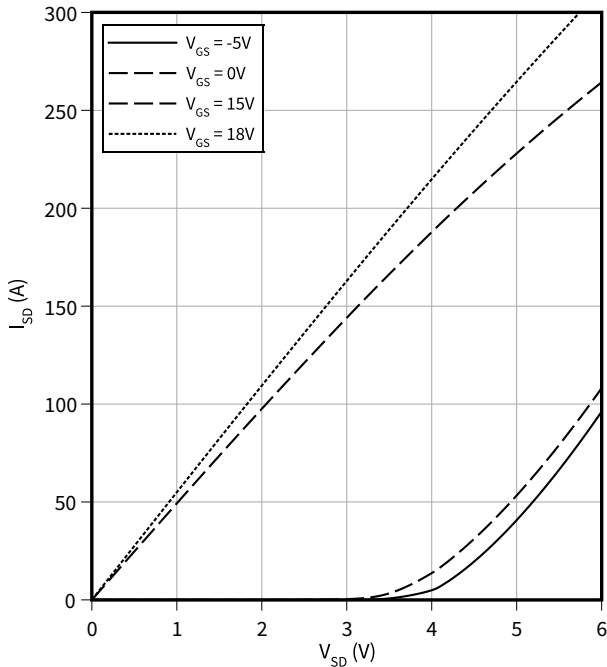
$V_{SD} = f(T_{vj})$   
 $I_{SD} = 54.3 \text{ A}, V_{GS} = 0 \text{ V}$



4 Characteristics diagrams

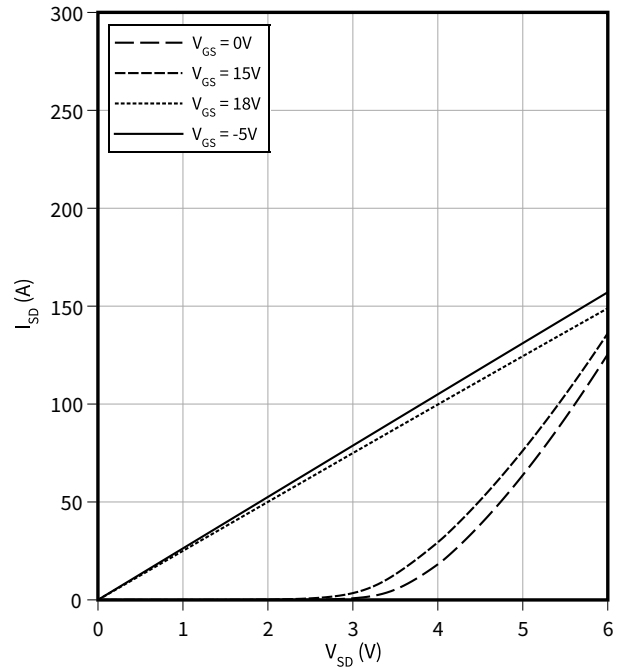
**Typical reverse drain current as function of reverse drain voltage,  $V_{GS}$  as parameter, MOSFET**

$I_{SD} = f(V_{SD})$   
 $T_{vj} = 25\text{ °C}$ ,  $t_p = 20\text{ }\mu\text{s}$



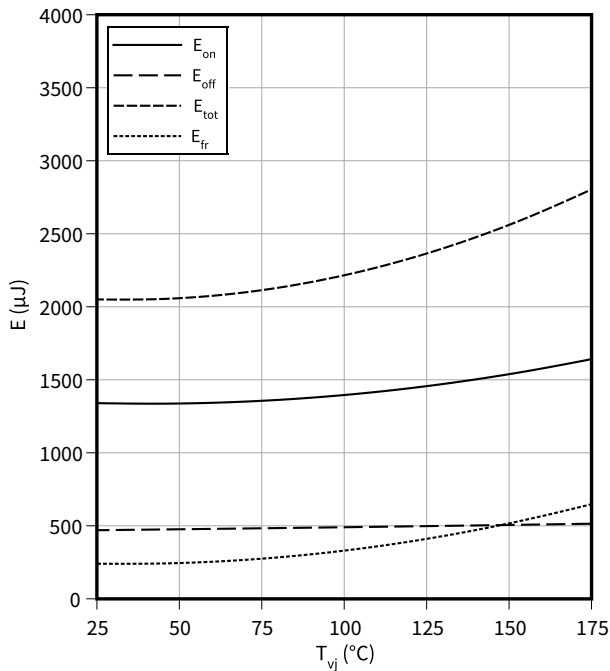
**Typical reverse drain current as function of reverse drain voltage,  $V_{GS}$  as parameter, MOSFET**

$I_{SD} = f(V_{SD})$   
 $T_{vj} = 175\text{ °C}$ ,  $t_p = 20\text{ }\mu\text{s}$



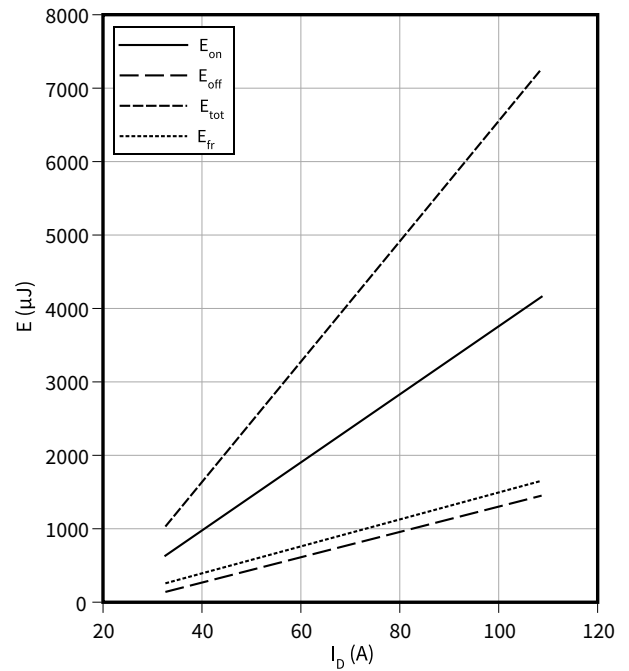
**Typical switching energy as a function of junction temperature, test circuit in Fig. F, 2nd device own body diode:  $V_{GS} = 0\text{ V}$ , MOSFET**

$E = f(T_{vj})$   
 $V_{GS} = 0/18\text{ V}$ ,  $I_D = 54.3\text{ A}$ ,  $R_{G,ext} = 1\text{ }\Omega$ ,  $V_{DD} = 800\text{ V}$



**Typical switching energy as a function of drain current, test circuit in Fig. F, 2nd device own body diode:  $V_{GS} = 0\text{ V}$ , MOSFET**

$E = f(I_D)$   
 $V_{GS} = 0/18\text{ V}$ ,  $T_{vj} = 175\text{ °C}$ ,  $R_{G,ext} = 1\text{ }\Omega$ ,  $V_{DD} = 800\text{ V}$

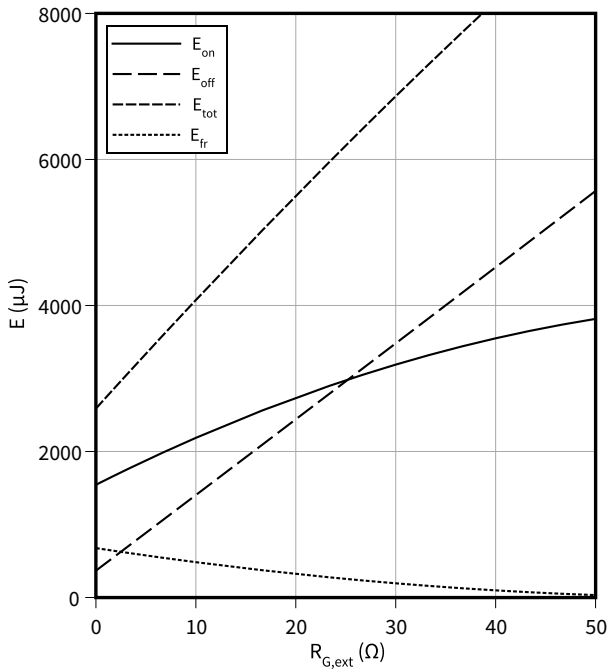


4 Characteristics diagrams

**Typical switching energy losses as a function of gate resistance, test circuit in Fig. F, 2nd device own body diode:  $V_{GS} = 0$  V, MOSFET**

$E = f(R_{G,ext})$

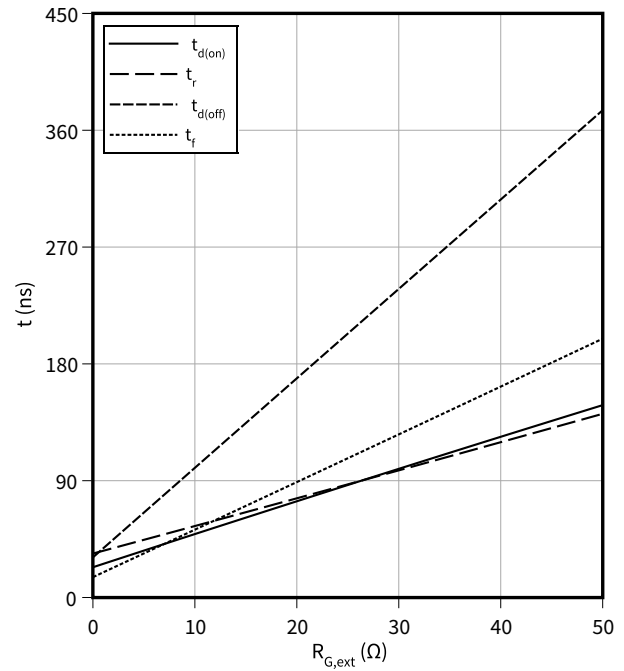
$I_D = 54.3$  A,  $T_{vj} = 175$  °C,  $V_{DD} = 800$  V,  $V_{GS} = 0/18$  V



**Typical switching times as a function of gate resistance, test circuit in Fig. F, 2nd device own body diode:  $V_{GS} = 0$  V, MOSFET**

$t = f(R_{G,ext})$

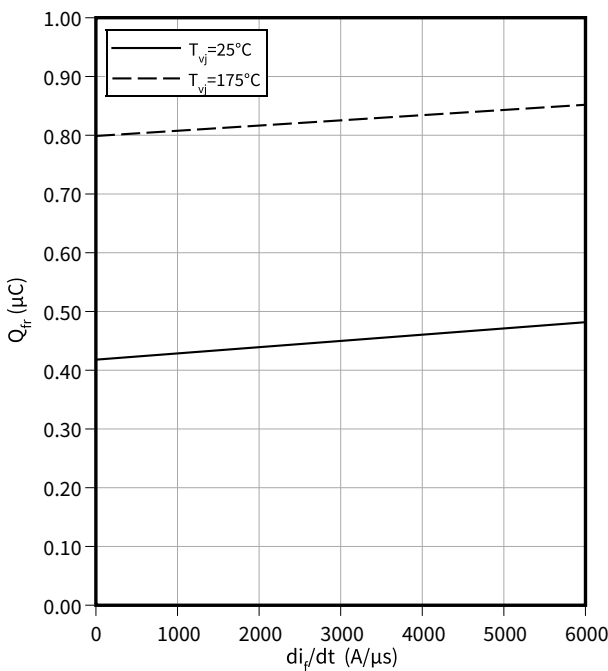
$V_{GS} = 0/18$  V,  $I_D = 54.3$  A,  $T_{vj} = 175$  °C,  $V_{DD} = 800$  V



**Typical reverse recovery charge as a function of reverse drain current slope, test circuit in Fig. F, 2nd device own body diode:  $V_{GS} = 0$  V, MOSFET**

$Q_{fr} = f(di_f/dt)$

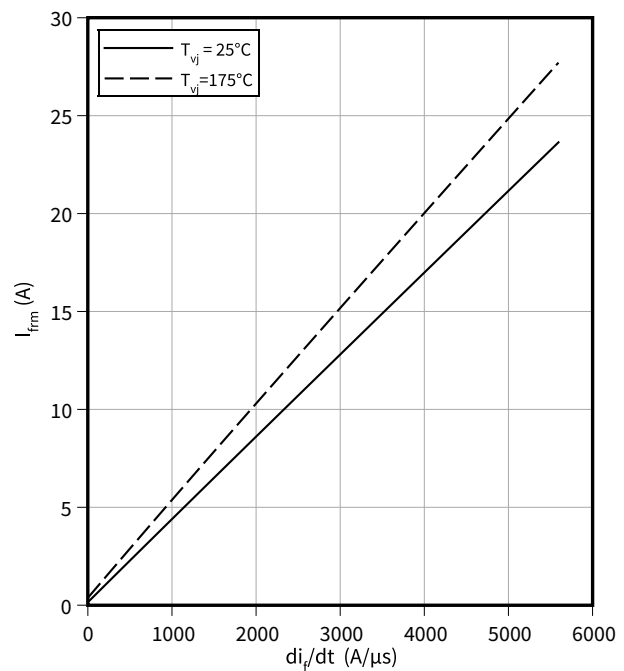
$V_{GS} = 0/18$  V,  $I_D = 54.3$  A,  $V_{DD} = 800$  V



**Typical reverse recovery current as a function of reverse drain current slope, test circuit in Fig. F, 2nd device own body diode:  $V_{GS} = 0$  V, MOSFET**

$I_{frm} = f(di_f/dt)$

$V_{GS} = 0/18$  V,  $I_D = 54.3$  A,  $V_{DD} = 800$  V

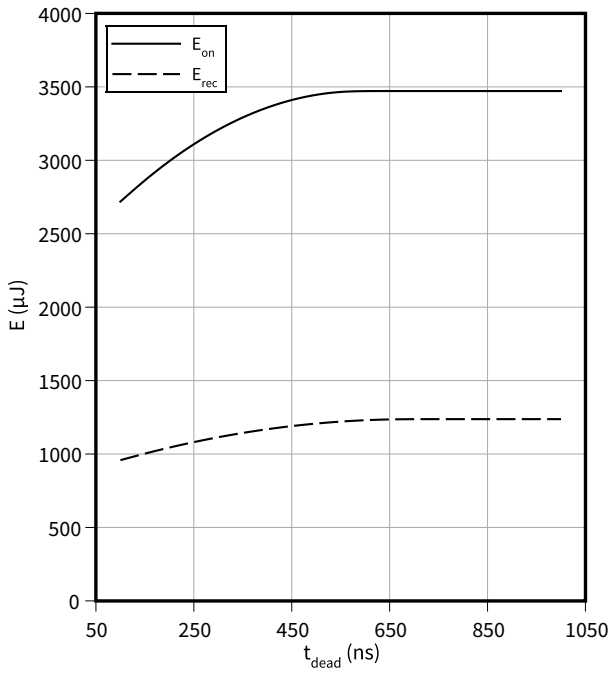


4 Characteristics diagrams

**Typical switching energy losses as a function of dead time / blanking time, test circuit in Fig. F, 2nd device own body diode:  $V_{GS} = -5$  V, MOSFET**

$E = f(t_{dead})$

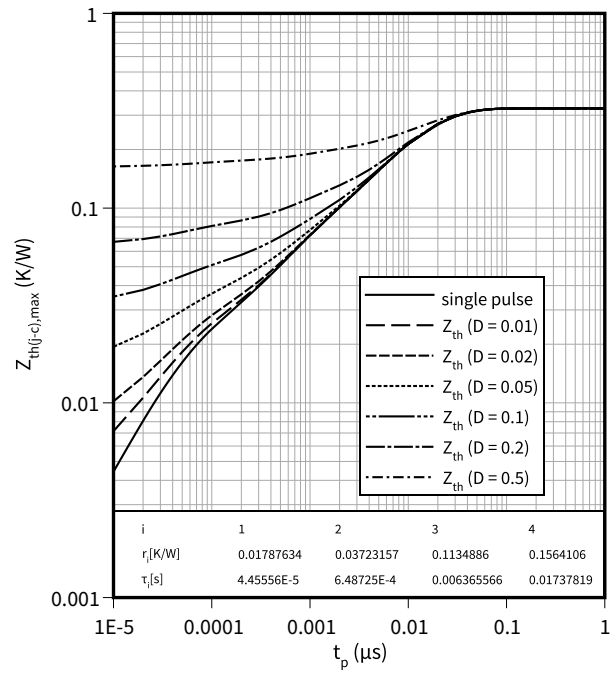
$I_D = 54.3$  A,  $T_{vj} = 175$  °C,  $V_{GS} = -5/18$  V,  $V_{DD} = 800$  V



**Max. transient thermal impedance (MOSFET/diode), MOSFET**

$Z_{th(j-c),max} = f(t_p)$

$D = t_p/T$



5 Package outlines

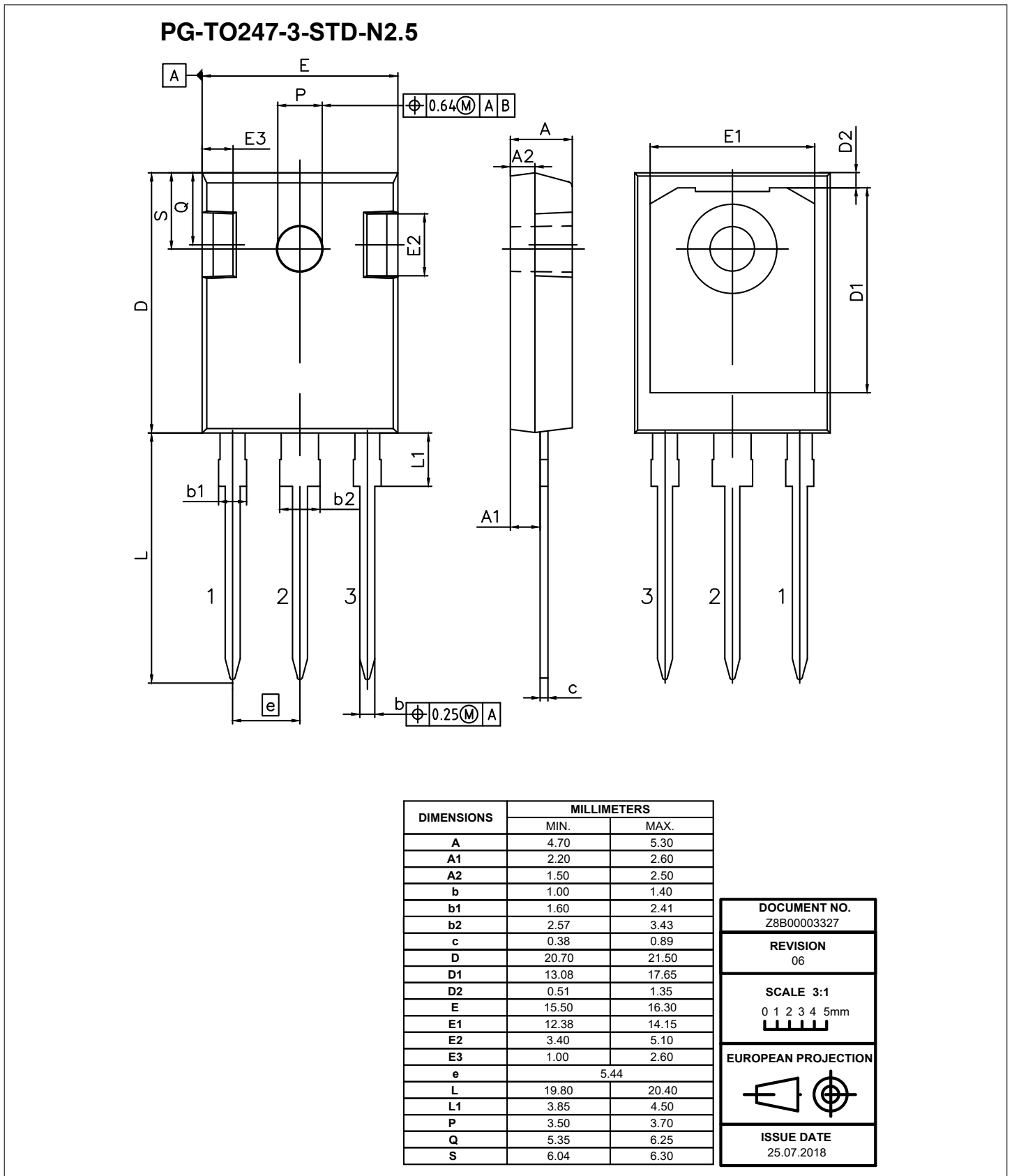


Figure 1

## 6 Testing conditions

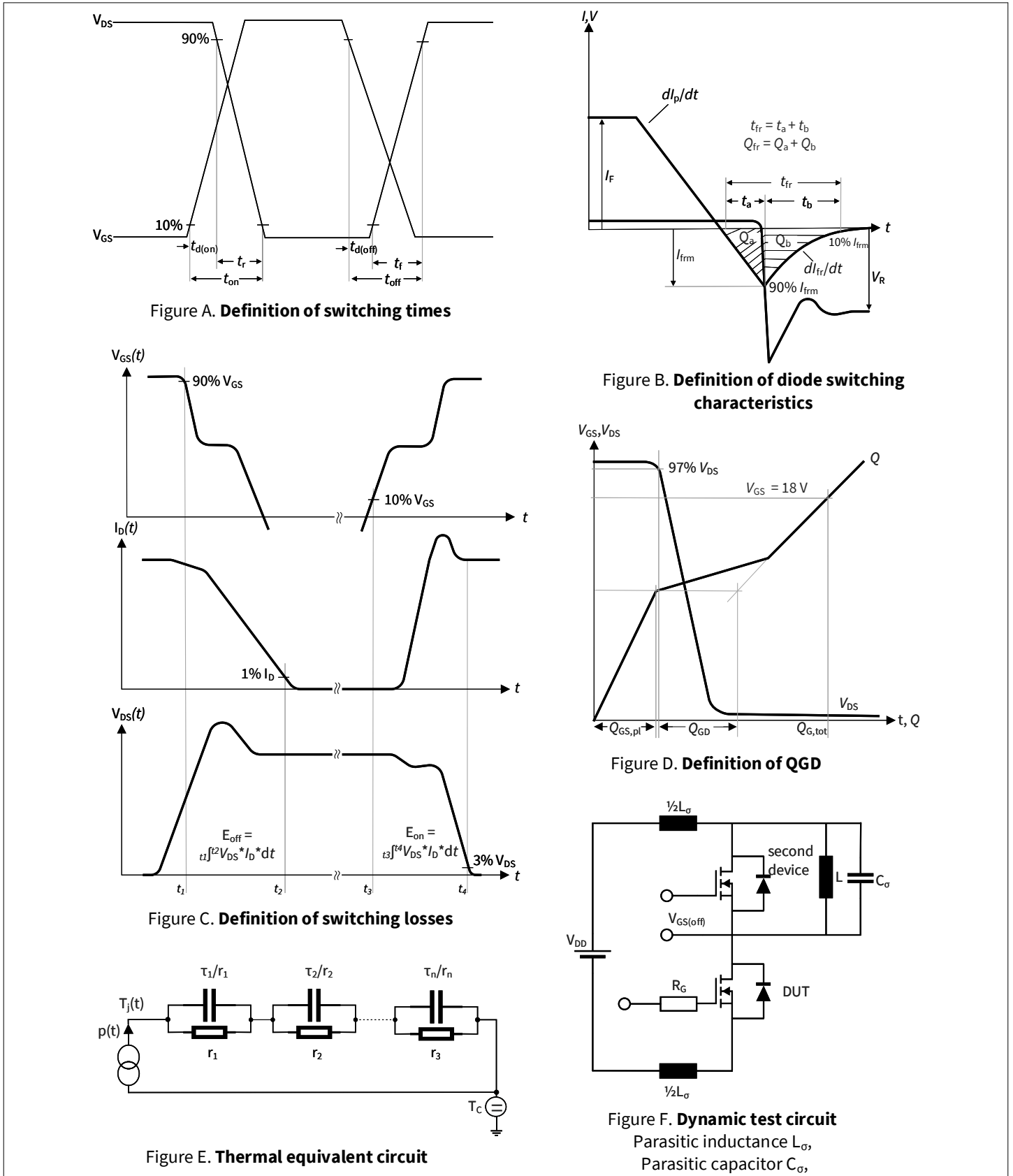


Figure 2

## Revision history

| Document revision | Date of release | Description of changes |
|-------------------|-----------------|------------------------|
| 1.00              | 2022-01-31      | Final datasheet        |



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